

<b>Notice of References Cited</b>	Application/Control No. 10/661,746	Applicant(s)/Patent Under Reexamination HSIEH, CHIA-TA	
	Examiner Eric B. Chen	Art Unit 1765	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,486,032	11-2002	Lin et al.	438/266
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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